


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/605,811	HAYASHI ET AL.	
	Examiner	Art Unit	
	Eric B. Compton	3726	

SEARCHED			
Class	Subclass	Date	Examiner
29	898.02	6/16/2005	EC
	724		
141	5		
	8		
184	7.4		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR